



<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <small>(use as many sheets as necessary)</small>		<i>Complete If Known</i>	
		Application Number	10/081,424
		Filing Date	February 22, 2002
		First Named Inventor	Jan ISAKSSON
		Group Art Unit	2827
		Examiner Name	J. Mitchell
Sheet 1	of 1	Attorney Docket No.	23027

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document No.	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figs. Appear
<i>JMM</i>		5,416,872	Sizer II et al.	05-16-1995	
		5,574,814	Noddings et al.	11-12-1996	
<i>JMM</i>		5,917,976	Yamaguchi	06-29-1999	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Office <sup>2</sup>	Number <sup>3</sup>			
<i>JMM</i>		DE	196 43 911	Sick AG	10-30-1996	

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>4</sup>
<i>JMM</i>		Wipiejewski et al, "Efficient Alignment Tolerant Coupling of Vertical-Cavity Lasers to Single-Mode Fibers", Proceedings of The European Conference on Sep. 12-16, 1993, Regular Papers, Zurich, Vol. 2, Conf. 19, Pages 333-336	
		Duthie et al., "Passively Aligned Four-Channel Reflective InP MQW Modulator Transmitter", Electronics Letters, July 6, 1999, IEE Stevncage, GB, Vol. 31, NR. 14, Pages 1177-1179	
		Holm et al., "Through-Etched Silicon Carriers for Passive Alignment of Optical Fibers to Surface-Active Optoelectronic Components", Sensors and Actuators A, Elsevier Sequoia S.A., Lausanne, CH, Vol. 82, Nr. 1-3, Pages 245-248	
<i>JMM</i>		Morozov et al., "Tolerance Analysis for Three-Dimensional Optoelectronic Systems Packaging", Optical Engineering, Soc. of Photo-Optical Instrumentation Engineers, Bellingham, US, Vol. 35, Nr. 7, Pages 2034-2043	

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.  
<sup>1</sup>Unique citation designation number. <sup>2</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>3</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>4</sup>Applicant is to place a check mark here if English language translation is attached.  
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